L Number	Hits	Search Text	DB	Time stamp
1	4804	382/181,190,199,203,204,276,286.ccls.	USPAT;	2004/11/08 16:58
	100		US-PGPUB;	
			EPO; JPO;	
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_		222 / 2	IBM_TDB	
2	813			2004/11/08 16:59
		circle	US-PGPUB; EPO; JPO;	
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3	168	382/181,190,199,203,204,276,286.ccls. and		2004/11/08 17:04
		(circle with (edge or contour))	US-PGPUB;	
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4	1000571		IBM_TDB	2004/11/20 17 24
4	1823571	382/181,190,199,203,204,276,286.ccls. and (circle with (edge or contour)) with	d USPAT; US-PGPUB;	2004/11/08 17:04
		inside or outside	EPO; JPO;	
		inside of outside	DERWENT;	
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5	. 17	382/181,190,199,203,204,276,286.ccls. and		2004/11/08 17:08
		(circle with (edge or contour)) with	US-PGPUB;	
		(inside or outside or exterior or	EPO; JPO;	· · ·
		interior)	DERWENT;	
-			IBM_TDB	
6	1987	1 '	USPAT;	2004/11/08 17:08
		(inside or outside or exterior or interior)	US-PGPUB;	
		interior,	EPO; JPO; DERWENT;	
			IBM TDB	
7	1	(circle with (edge or contour)) with	USPAT;	2004/11/08 17:09
	-	(inside or outside or exterior or	US-PGPUB;	
		interior) with gradient	EPO; JPO;	
			DERWENT;	
0.			IBM_TDB	
8	57	1	USPAT;	2004/11/08 17:41
		(inside or outside or exterior or interior) with image	US-PGPUB; EPO; JPO;	
	-	interior, with image	DERWENT;	
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9	165	382/204.ccls.	USPĀT;	2004/11/08 17:41
	ĺ		US-PGPUB;	
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11	191	382/203.ccls. and circle	USPĀT;	2004/11/08 17:50
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12	3	382/203.ccls. and circle with (foreign or		2004/11/08 17:49
		unwanted or artifact or remains)	US-PGPUB;	
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13	4	382/203.ccls. and circle with outside	USPAT;	2004/11/08 17:50
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14	20	382/203.ccls. and circle with (outside or		2004/11/08 17:52
		exterior or outer)	US-PGPUB;	
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15	353	fang with t	USPAT; US-PGPUB;	2004/11/08 17:52
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18	250	fang and circle and gradient	US-PGPUB;	2004/11/08 17:53
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19	186	fang and circle and gradient and center	USPAT;	2004/11/08 17:53
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	1	and center	US-PGPUB;	2001,11,001,101
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O- By Author O- Basic O- Advanced O- CrossRef  Member Services	1 Automatic concentricity measurement by image processing Hsieh Chen-Huei; Huang Yue-Wei; Wu Menq-Jiun; Instrumentation and Measurement Technology Conference, 1994. IMTC/94. Conference Proceedings. 10th Anniversary. Advanced Technologies in I & M., IEEE, 10-12 May 1994				
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